

PERRY JOHNSON LABORATORY ACCREDITATION, INC.

Certificate of Accreditation

Perry Johnson Laboratory Accreditation, Inc. has assessed the Laboratory of:

JOULÉ, Equipment Services 1777 Sentry Park West, Suite 201, Blue Bell, PA 19422

(Hereinafter called the Organization) and hereby declares that Organization is accredited in accordance with the recognized International Standard:

ISO/IEC 17025:2017

This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (as outlined by the joint ISO-ILAC-IAF Communiqué dated April 2017):

Calibration of Electrical, Time & Frequency, Mechanical, Mass, Force & Weighing and Thermodynamics Instruments (As detailed in the supplement)

Accreditation claims for such testing and/or calibration services shall only be made from addresses referenced within this certificate. This Accreditation is granted subject to the system rules governing the Accreditation referred to above, and the Organization hereby covenants with the Accreditation body's duty to observe and comply with the said rules.

For PJLA:

Liacy Szenszen

Tracy Szerszen President

Perry Johnson Laboratory Accreditation, Inc. (PJLA) 755 W. Big Beaver, Suite 1325 Troy, Michigan 48084

 Initial Accreditation Date:
 Issue Date:
 Expiration Date:

 September 22, 2012
 November 28, 2022
 November 28, 2024

 Accreditation No.:
 Certificate No.:

 73879
 L22-795

The validity of this certificate is maintained through ongoing assessments based on a continuous accreditation cycle. The validity of this certificate should be confirmed through the PJLA website: <u>www.pjlabs.com</u>



JOULÉ, Equipment Services 1777 Sentry Park West, Suite 201, Blue Bell, PA 19422 Contact Name: Curt Blair Phone: 215-647-6000

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (+)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure	3 mV to 330 mV	$21 \mu\text{V/V} + 0.9 \mu\text{V}$	Fluke 5520A
DC Voltage ^{FO}	0.33 V to 3.3 V	13 μV/V + 3 μV	SWI: B2135
	3.3 V to 33 V	15 μV/V + 7 μV	
	33 V to 330 V	19 μV/V + 149 μV	
	330 V to 1 000 V	19 μV/V + 700 μV	
Equipment to Output	1 mV to 100 mV	9 μV/V + 1.6 μV	HP3458A
DC Voltage ^{FO}	0.1 V to 1V	$12 \mu V/V + 1.4 \mu V$	SWI: B2135
	1 V to 10 V	15 μV/V + 2.5 μV	
	10 V to 100 V	15 μV/V + 48 μV	
	100 V to 1 000 V	29 μV/V + 1.4 μV	
Equipment to Measure	10 µA to 330 µA	138 μA/A + 0.1 μA	Fluke 5520A
DC Current ^{FO}	0.33 mA to 3.3 mA	124 μA/A + 0.1 μA	SWI: B2135
	3.3 mA to 33 mA	141 μA/A + 0.05 μA	
	33 mA to 330 mA	145 μA/A + 0.07 μA	
	0.33 A to 1.1 A	251 µA/A + 0.2 mA	
	1.1 A to 3 A	398 µA/A + 0.2 mA	
	3 A to 11 A	620 μA/A + 0.9 mA	
Equipment to Output	0.1 mA to 1 mA	14 μΑ/Α + 0.9 μΑ	HP3458A
DC Current ^{FO}	1 mA to 10 mA	27 μΑ/Α + 0.8 μΑ	SWI: B2135
	10 mA to 100 mA	42 μΑ/Α + 0.7 μΑ	
	0.1 A to 1 A	127 μΑ/Α + 8 μΑ	
Equipment to Measure	1 Ω to 11 Ω	74 μ Ω/Ω + 1 m Ω	Fluke 5520A
Resistance ^{FO}	11 Ω to 110 Ω	$40 \ \mu\Omega/\Omega + 1.5 \ m\Omega$	SWI: B2135
	110 Ω to 1.1 kΩ	$61 \ \mu\Omega/\Omega + 0.9 \ m\Omega$	
	1.1 k Ω to 11 k Ω	$57 $ μ Ω/Ω + $5 $ m Ω	
	11 kΩ to 110 kΩ	$50 \mu\Omega/\Omega + 76 \mathrm{m}\Omega$	
	110 k Ω to 1.1 M Ω	$25 \mu\Omega/\Omega + 3 \Omega$	
	1.1 MΩ to 3.3 MΩ	71 μ Ω / Ω + 48 Ω	
	$3.3 \text{ M}\Omega$ to $11 \text{ M}\Omega$	130 μ Ω / Ω + 243 Ω	
	11 MΩ to 33 MΩ	$2.3 \text{ m}\Omega/\Omega + 2.4 \text{ k}\Omega$	
	33 MΩ to 110 MΩ	$0.55 \text{ m}\Omega/\Omega + 3.3 \text{ k}\Omega$	
	110 MΩ to 330 MΩ	$3.5 \text{ m}\Omega/\Omega + 0.3 \text{ M}\Omega$	
	330 M Ω to 1 100 M Ω	$16 \text{ m}\Omega/\Omega + 0.7 \text{ M}\Omega$	



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Electrical			
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Equipment to Output	1Ω to 10Ω	15 μΩ/Ω + 88 μΩ	HP3458A
Resistance ^{FO}	10 Ω to 100 Ω	35 μΩ/Ω + 100 μΩ	SWI: B2135
	100 Ω to 1 000 Ω	$25 \mu\Omega/\Omega + 0.8 \mathrm{m}\Omega$	
	1 k to 10 kΩ	$25 \mu\Omega/\Omega + 0.8 \mathrm{m}\Omega$	
	$10 \text{ k}\Omega$ to $100 \text{ k}\Omega$	$27 \ \mu\Omega/\Omega + 27 \ m\Omega$	
	$100 \text{ k}\Omega$ to $1 \text{ M}\Omega$	$28 \mu\Omega/\Omega + 0.2 \Omega$	
	$1 \text{ M}\Omega$ to $10 \text{ M}\Omega$	108 μΩ/Ω + 80 Ω	
	10 M Ω to 100 M Ω	$0.7 \text{ m}\Omega/\Omega + 0.6 \text{ k}\Omega$	
	100 MΩ to 500 MΩ	$7 m\Omega/\Omega + 6.5 k\Omega$	
Equipment to Measure AC	Voltage at the Listed Frequenc	ies ^{FO}	Fluke 5520A
10 Hz to 45 Hz	3 mV to 33 mV	592 μV/V + 125 μV	SWI: B2135
45 Hz to 10 kHz	3 mV to 33 mV	23 μV/V + 140 μV	
10 kHz to 20 kHz	3 mV to 33 mV	214 μV/V + 140 μV	
20 kHz to 50 kHz	3 mV to 33 mV	804 μV/V + 137 μV	
50 kHz to 100 kHz	3 mV to 33 mV	2.9 mV/V + 132 μV	
100 kHz to 500 kHz	3 mV to 33 mV	$49 \text{ mV/V} + 132 \mu \text{V}$	
Equipment to Measure AC	Voltage at the Listed Frequenc	ies ^{FO}	
10 Hz to 45 Hz	33 mV to 330 mV	317 μV/V + 46 μV	
45 Hz to 10 kHz	33 mV to 330 mV	254 μV/V + 26 μV	
10 kHz to 20 kHz	33 mV to 330 mV	234 μV/V + 39 μV	
20 kHz to 50 kHz	33 mV to 330 mV	417 μV/V + 21 μV	
50 kHz to 100 kHz	33 mV to 330 mV	863 μV/V + 34 μV	
100 kHz to 500 kHz	33 mV to 330 mV	1.4 mV/V + 140 μV	
Equipment to Measure AC	Voltage at the Listed Frequenc	ies ^{FO}	
10 Hz to 45 Hz	0.33 V to 3.3 V	$405 \mu \text{V/V} + 0.8 \text{mV}$	
45 Hz to 10 kHz	0.33 V to 3.3 V	$247 \mu V/V + 1 mV$	
10 kHz to 20 kHz	0.33 V to 3.3 V	$308 \mu V/V + 1 mV$	
20 kHz to 50 kHz	0.33 V to 3.3 V	$289 \mu V/V + 2 mV$	
50 kHz to 100 kHz	0.33 V to 3.3 V	1.5 mV/V + 5 mV	
100 kHz to 500 kHz	0.33 V to 3.3 V	1.9 μV/V + 5 mV	



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Equipment to Measure AC	Voltage at the Listed Frequence	ries ^{FO}	Fluke 5520A
10 Hz to 45 Hz	3.3 V to 33 V	$298 \mu V/V + 2 mV$	SWI: B2135
45 Hz to 10 kHz	3.3 V to 33 V	$237 \mu V/V + 1.6 mV$	
10 kHz to 20 kHz	3.3 V to 33 V	$295 \mu V/V + 3 mV$	
20 kHz to 50 kHz	3.3 V to 33 V	$263 \mu V/V + 3 m V$	
50 kHz to 100 kHz	3.3 V to 33 V	1.2 mV/V + 18 mV	
Equipment to Measure AC	Voltage at the Listed Frequence	ies ^{FO}	
45 Hz to 1 kHz	33 V to 330 V	$267 \mu V/V + 2 mV$	
1 kHz to 10 kHz	33 V to 330 V	$551 \mu V/V + 5 mV$	
10 kHz to 20 kHz	33 V to 330 V	$440 \mu V/V + 3 mV$	
20 kHz to 50 kHz	33 V to 330 V	$618 \mu V/V + 2 mV$	
50 kHz to 100 kHz	33 V to 330 V	1.7 mV/V + 71 mV	-
Equipment to Measure AC	1		
45 Hz to 1 kHz	330 V to 1 020 V	$372 \mu V/V + 10 mV$	-
1 kHz to 5 kHz	330 V to 1 020 V	$324 \mu V/V + 59 mV$	
5 kHz to 10 kHz	330 V to 1 020 V	$249 \mu V/V + 71 m V$	
Equipment to Output AC Vo	oltage at the Listed Frequencie	es FO	HP3458A
1 Hz to 1 kHz	10 mV to 100 mV	$5 \mu V/V + 8 \mu V$	SWI: B2135
1 Hz to 1 kHz	100 mV to 1 V	8 μV/V + 8 μV	
1 Hz to 1 kHz	1 V to 10 V	12 μV/V + 3 μV	
1 Hz to 1 kHz	10 V to 100 V	$46 \mu V/V + 0.3 m V$	
1 Hz to 1 kHz	100 V to 1 000 V	$61 \mu V/V + 2 mV$	
Equipment to Measure AC (
45 Hz to 1 kHz	29 µA to 330 µA	0.13 % + 0.12 μA	Fluke 5520A
45 Hz to 1 kHz	0.33 mA to 3.3 mA	0.17 % + 2 μA	SWI: B2135
45 Hz to 1 kHz	3.3 mA to 33 mA	0.03 % + 12 μA	
45 Hz to 1 kHz	33 mA to 330 mA	0.06 % + 13 μA	
45 Hz to 1 kHz	0.33 A to 1.1 A	0.04 % + 125 μA	
45 Hz to 1 kHz	1.1 A to 3 A	0.1 % + 57 μA	
45 Hz to 1 kHz	3 A to 11 A	0.1 % + 1 mA	
1 kHz to 5 kHz	3 A to 11 A	2.3 % + 6 mA	1



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Equipment to Output AC C	urrent at the listed Frequencie	s ^{FO}	
45 Hz to 5 kHz	1 to 10 mA	10 μA/A + 3 μA	HP3458A
45 Hz to 5 kHz	10 to 100 mA	336 µA/A + 0.4 µA	SWI: B2135
45 Hz to 5 kHz	0.1 to 1 A	376 µA/A + 4 µA	
Equipment to Measure	1.1 nF to 3.299 9 nF	0.5 % + 0.01 nF	Fluke 5520A
Capacitance ^{FO}	3.3 nF to 10.999 9 µF	0.25 % + 0.03 nF	SWI: B2135
	0.33 μF to 1.099 99 μF	0.25 % + 6 nF	-
	1.1 μF to 3.299 99 μF	0.25 % + 4 nF	-
	3.3 μF to 10.999 9 μF	0.25 % + 13 nF	-
Temperature Calibration,	-210 °C to -100 °C	0.56 °C	Fluke 5520A
Indication and Control	-100 °C to -30 °C	0.30 °C	Electrical Simulation of
Equipment used with Thermocouple Type I	-30 °C to 150 °C	0.26 °C	- Thermocouple Output SWI·B2100
(Resolution = 0.1° C) ^{FO}	150 °C to 760 °C	0.39 °C	5 W1.D2100
	760 °C to 1 200 °C	0.63 °C	-
Temperature Calibration,	-200 °C to -100 °C	0.52 °C	Fluke 5520A Electrical Simulation of Thermocouple Output SWI:B2100
Indication and Control	-100 °C to -25 °C	0.31 °C	
Equipment used with Thermocouple Type K	-25 °C to 120 °C	0.33 °C	
(Resolution = 0.1° C) ^{FO}	120 °C to 1 000 °C	0.55 °C	
	1 000 °C to1 372 ° C	0.66 °C	
Temperature Calibration,	-250 °C to 150 °C	0.67 °C	Fluke 5520A
Indication and Control	-150 °C to 0 °C	0.32 °C	Electrical Simulation of
Thermocouple Type T	0 °C to 120 °C	0.33 °C	SWI-B2100
(Resolution = 0.1° C) ^{FO}	120 °C to 400 °C	0.56 °C	
Temperature Calibration,	-200 °C to 0 °C	0.28 °C	Fluke 5520A
Indication and Control	0 °C to 100 °C	0.17 °C	Electrical Simulation of
Equipment used with RTD 385 100 Ω RTD ^{FO}	100 °C to 400 °C	0.18 °C	SWI·B2100
	400 °C to 630 °C	0.24 °C	
	630 °C to 800 °C	0.27 °C	
Temperature Calibration,	-200 °C to 0 °C	0.19 °C	Fluke 5520A
Indication and Control	0 °C to 100 °C	0.13 °C	Electrical Simulation of
RTD 3926 100 Ω^{FO}	100 °C to 300 °C	0.27 °C	SWI:B2100
	300 °C to 400 °C	0.29 °C	
	400 °C to 630 °C	0.32 °C	



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Accreditation is granted to the facility to perform the following calibrations:

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Temperature Calibration, Indication and Control Equipment used with RTD 385 1 $k\Omega^{FO}$	-200 °C to 0 °C	0.31 °C	Fluke 5520A Electrical Simulation of RTD Output SWI:B2100
	0 °C to 100 °C	0.18 °C	
	100 °C to 300 °C	0.23 °C	
	300 °C to 600 °C	0.30 °C	
	600 °C to 630 °C	0.34 °C	

Time and Frequency

MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Equipment to Measure	1 Hz to 1.2 kHz	1.7 mHz/Hz + 12 mHz	Fluke 5520A
Frequency ^{FO}	1.2 kHz to 120 kHz	97.8 μHz/Hz + 1.2 Hz	SWI: B2135
Equipment to Output Frequency ^{FO}	1 Hz to 100 MHz	0.66 µHz/Hz + 0.2 mHz	Fluke PM6666 1s Time base SWI:B2135
Timers and Stopwatches ^{FO}	10 s to 24 hr	0.26 s/d	Fluke PM6666 SWI: B2800

Mechanical

Meenumeur			
MEASURED INSTRUMENT, QUANTITY OR GAUGE	RANGE OR NOMINAL DEVICE SIZE AS APPROPRIATE	CALIBRATION AND MEASUREMENT CAPABILITY EXPRESSED AS AN UNCERTAINTY (±)	CALIBRATION EQUIPMENT AND REFERENCE STANDARDS USED
Pressure Gages and	Up to 9 psi	0.006 psi	Crystal n-Vision Module
Measuring Devices ^{FO}	9 psi to 30 psi	0.02 psi	30 PSI SWI:B2000
	-14 psi to 0 psi	0.02 psi	Crystal n-Vision Module
	30 psi to 90 psi	0.05 psi	300 PSI SWI:B2000
	90 psi to 300 psi	0.16 psi	
	300 psi to 900 psi	0.92 psi	Crystal n-Vision Module
	900 psi to 3 000 psi	3 psi	3 000 PSI SWI:B2000
	3 000 psi to 10 000 psi	20 psi	Crystal n-Vision Module
			10 000 PSI
			SWI:B2000



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Balances and Scales ^{FO}	1 mg to 500 mg	0.03 mg	Class 1 Weights
	500 mg to 100 g	0.08 mg	SWI: B2600
	100 g to 200 g	0.1 mg	
	200 g to 500 g	1.1 mg	
	500 g to 1 kg	5.6 mg	
	1 kg to 5 kg	8.3 mg	
	5 kg to 10 kg	28 mg	
	10 kg to 20 kg	56 mg	
	20 kg to 30 kg	84 mg	
Pipette ^F	1 μL	0.04 μL	AnD HM202 Balance /
	2 μL	0.05 μL	Gravimetric Analysis
	5 µL	0.06 µL	5 WI. D2000
	10 µL	0.06 μL	
	20 µL	0.07 μL	
	50 µL	0.11 μL	
	100 µL	0.23 μL	
	200 µL	0.34 µL	
	500 μL	0.96 µL	
	1 000 µL	2.6 μL	
	5 000 μL	10 μL	
	10 000 μL	19 µL	

Mass, Force, and Weighing Device

Thermodynamic

MEASURED INSTRUMENT,	RANGE OR NOMINAL	CALIBRATION AND	CALIBRATION
QUANTITY OR GAUGE	DEVICE SIZE AS	MEASUREMENT	EQUIPMENT
	APPROPRIATE	CAPABILITY EXPRESSED	AND REFERENCE
		AS AN UNCERTAINTY (±)	STANDARDS USED
Humidity Measuring	10 % RH to 90 % RH	1.0% RH at 25 °C	Kaymont M2000SP
Devices ^{FO}			SWI: B2150
Liquid-in-Glass	-80 °C to 0 °C	0.42 °C	Fluke 5520A,GE M2801,
Thermometers and	0.1 °C to 100 °C	0.28 °C	Fluke 5628, constant
Tomporatura Magguring	0.1 C 10 100 C	0.28 C	tomporature liquid both
Devices ^{FO}	100.1 °C to 300 °C	0.37 °C	dry well constant temperature block SWI: B2100
	300.1 °C to 600 °C	0.58 °C	
	600.1 °C to 900 °C	0.86 °C	



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- 1. The CMC (Calibration and Measurement Capability) stated for calibrations included on this scope of accreditation represents the smallest measurement uncertainty attainable by the laboratory when performing a more or less routine calibration of a nearly ideal device under nearly ideal conditions. It is typically expressed at a confidence level of 95 % using a coverage factor k (usually equal to 2). The actual measurement uncertainty associated with a specific calibration performed by the laboratory will typically be larger than the CMC for the same calibration since capability and performance of the device being calibrated and the conditions related to the calibration may reasonably be expected to deviate from ideal to some degree.
- 2. The laboratories range of calibration capability for all disciplines for which they are accredited is the interval from the smallest calibrated standard to the largest calibrated standard used in performing the calibration. The low end of this range must be an attainable value for which the laboratory has or has access to the standard referenced. Verification of an indicated value of zero in the absence of a standard is common practice in the procedure for many calibrations but by its definition it does not constitute calibration of zero capacity.
- 3. The presence of a superscript FO means that the laboratory performs calibration of the indicated parameter both at its fixed location and onsite at customer locations. Example: Outside Micrometer^{FO} would mean that the laboratory performs this calibration at its fixed location and onsite at customer locations.
- 4. Measurement uncertainties obtained for calibrations performed at customer sites can be expected to be larger than the measurement uncertainties obtained at the laboratories fixed location for similar calibrations. This is due to the effects of transportation of the standards and equipment and upon environmental conditions at the customer site which are typically not controlled as closely as at the laboratories fixed location.